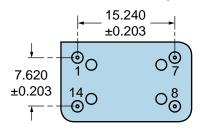


ELECTRICAL SPECIFICATIONS		
Nominal Frequency	18.414MHz	
Initial Tolerance	±2.5ppm Maximum (Measured at Nominal Vdd and Vc)	
Frequency Stability	±3.0ppm Maximum	
Frequency Stability vs. Input Voltage	±0.3ppm Maximum (Vdd ±5%)	
Frequency Stability vs. Aging	±1ppm/Year Maximum (at 25°C)	
Frequency Stability vs. Load	±0.2ppm Maximum (±10%)	
Operating Temperature Range	-40°C to +85°C	
Supply Voltage	3.3Vdc ±5%	
Input Current	10mA Maximum (Measured at Steady State at 25°C)	
Output Voltage	0.7Vp-p Minimum Clipped Sinewave	
Load Drive Capability	10kOhms//10pF	
Output Logic Type	Clipped Sinewave	
Control Voltage	None (No Connect on Pin 1)	
Input Impedance	10kOhms Typical	
Phase Noise	-70dBc/Hz at 10Hz Offset, -100dBc/Hz at 100Hz Offset, -130dBc/Hz at 1kHz Offset, -140dBc/Hz at 10kHz Offset, -145dBc/Hz at 100kHz Offset (Typical Values at 19.440MHz)	
Storage Temperature Range	-55°C to +125°C	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
Fine Leak Test	MIL-STD-883, Method 1014 Condition A	
Gross Leak Test	MIL-STD-883, Method 1014 Condition C	
Lead Integrity	MIL-STD-883, Method 2004	
Mechanical Shock	MIL-STD-202, Method 213 Condition C	
Resistance to Soldering Heat	MIL-STD-202, Method 210	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010	
Vibration	MIL-STD-883, Method 2007 Condition A	



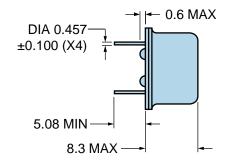
MECHANICAL DIMENSIONS (all dimensions in millimeters)



MARKING

ORIENTATION

 20.3 ± 0.5



PIN	CONNECTION
1	No Connect
7	Case Ground
8	Output
14	Supply Voltage

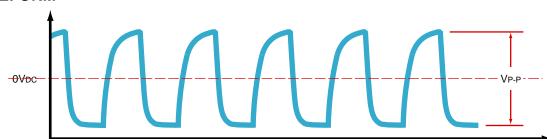
LINE	MARKING
1	ECLIPTEK
2	18.414M
3	XXYZZ XX=Ecliptek Manufacturing Code Y=Last Digit of the Year ZZ=Week of the Year

OUTPUT WAVEFORM

13.0

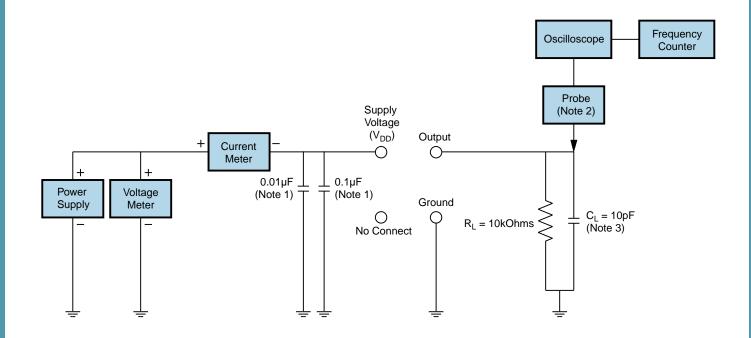
±0.5

CLOCK OUTPUT





Test Circuit for No Connect Option



- Note 1: An external $0.1\mu F$ low frequency tantalum bypass capacitor in parallel with a $0.01\mu F$ high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value \dot{C}_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



Low Temperature Solder Bath (Wave Solder)

T _S MAX to T _L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _S TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	30 - 60 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	245°C Maximum
Target Peak Temperature (T _P Target)	245°C Maximum 1 Time / 235°C Maximum 2 Times
Time within 5°C of actual peak (tp)	5 seconds Maximum 1 Time / 15 seconds Maximum 2 Times
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.